High Speed Quad MOSFET Driver

Features

- ▶ 6.0ns rise and fall time with 1000pF load
- 2.0A peak output source/sink current
- ▶ 1.8 to 5.0V input CMOS compatible
- 5.0 to 12V total supply voltage
- Smart logic threshold
- Low jitter design
- Four matched channels
- Outputs can swing below ground
- Output is high impedence when disabled
- Low inductance package
- ► High-performance thermally-enhanced QFN

Applications

- Medical ultrasound imaging
- Piezoelectric transducer drivers
- Non-Destructive Testing (NDT)
- PIN diode driver
- CCD Clock driver/buffer
- High speed level translator

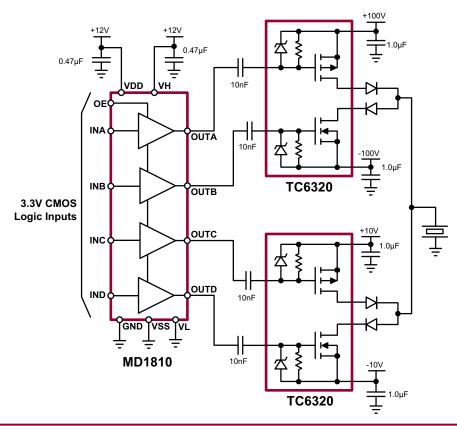
General Description

The Supertex MD1810 is a high-speed quad MOSFET driver. It is designed to drive high voltage P- and N-channel MOSFETs for medical ultrasound imaging applications. The MD1810 can also be used for ultrasound metal flaw detection, Non-Destructive Testing (NDT), piezoelectric transducer drive, clock drive, and PIN diode drive.

The MD1810 has four inputs which individually control four outputs. It also has an output enable (OE) pin. When OE is low, all of the outputs will be in a high impedence state regardless of their logic input control. When OE is high, the MD1810 sets the threshold logic transition to $(V_{OE}^+V_{GND}^-)/2$. This ensures the transition to always be at half the amplitude of the logic input signal. This allows the device to have inherent propagation delay matching regardless of the logic input amplitude.

The output stage of the MD1810 has separate power connections enabling the output signal L and H levels to be chosen independently from the $V_{\rm DD}$ and $V_{\rm SS}$ supply voltages. As an example, the input logic levels may be 0 and 1.8V, the control logic may be powered by +5.0 and -5.0V, and the output L and H levels may be varied anywhere over the range of -5.0 to +5.0V. The output stage is capable of peak currents of up to $\pm 2.0A$, depending on the supply voltages used and

Typical Application Circuit



Ordering Information

Device	16-Lead QFN 4.00x4.00mm body 1.00mm height (max) 0.65mm pitch
MD1810	MD1810K6-G

⁻G indicates package is RoHS compliant ('Green')

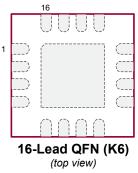
Absolute Maximum Ratings

Parameter	Value
V _{DD} -V _{SS} , Logic supply voltage	-0.5V to +13.5V
V _H , Output high supply voltage	V_{L} - 0.5V to V_{DD} +0.5V
V _L , Output low supply voltage	V_{SS} - 0.5V to V_H + 0.5V
V _{ss} , Low side supply voltage	-7.0V to +0.5V
Logic input levels	V _{ss} - 0.5V to GND +7V
Maximum junction temperature	+125°C
Storage temperature	-65°C to 150°C
Operating temperature	-20°C to +85°C
Package power dissipation	2.2W
Thermal resistance $(\theta_{JA})^*$	45°C/W

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied. Continuous operation of the device at the absolute rating level may affect device reliability. All voltages are referenced to device ground.



Pin Configuration



Product Marking



Y = Last Digit of Year Sealed W = Code for Week Sealed L = Lot Number

___ = "Green" Packaging

Package may or may not include the following marks: Si or

16-Lead QFN (K6)

DC Electrical Characteristics $(V_H = V_{DD} = 12V, V_L = V_{SS} = GND = 0V, V_{OE} = 3.3V, T_A = 25^{\circ}C)$

Sym	Parameter	Min	Тур	Max	Units	Conditions
V _{DD} - V _{SS}	Logic supply voltage	4.5	-	13	V	2.5V ≤ V _{DD} ≤13V
V _{ss}	Low side supply voltage	-5.5	-	0	V	
V _H	Output high supply voltage	V _{ss} +2	1	V _{DD}	V	
$V_{\scriptscriptstyle L}$	Output low supply voltage	V _{ss}	ı	V _{DD} -2	V	
I _{DDQ}	V _{DD} quiescent current	-	8.0	_	mA	No input transitions OF - 1
I _{HQ}	V _H quiescent current	-	-	10	μA	No input transitions, OE = 1
I _{DD}	V _{DD} average current	-	7.0	-	mA	One channel on at 5.0Mhz,
I _H	V _H average current	-	18	-	mA	No load
V _{IH}	Input logic voltage high	V _{OE} -0.3	-	5.0	V	
V _{IL}	Input logic voltage low	0	-	0.3	V	For logic inputs INA, INB, INC, and
I _{IH}	Input logic current high	-		1.0	μA	IND
I _{IL}	Input logic current low	-	-	1.0	μA	
V _{IH}	OE input logic voltage high	1.7	-	5.0	V	
V _{IL}	OE input logic voltage low	0	-	0.3	V	For logic input OE
R _{IN}	Input logic impedance to GND	10	20	30	ΚΩ	
C _{IN}	Logic input capacitance	-	5.0	10	pF	

^{* 1.0}oz 4-layer 3x4" PCB

DC Electrical Characteristics (cont.) $(V_H = V_{DD} = 12V, V_L = V_{SS} = GND = 0V, V_{OE} = 3.3V, T_A = 25^{\circ}C)$

Sym	Parameter	Min	Тур	Max	Units	Conditions
R _{SINK}	Output sink resistance	-	-	12.5	Ω	I _{SINK} = 50mA
R _{SOURCE}	Output source resistance	-	-	12.5	Ω	I _{SOURCE} = 50mA
I _{SINK}	Peak output sink current	-	2.0	-	Α	
I _{SOURCE}	Peak output source current	-	2.0	-	Α	

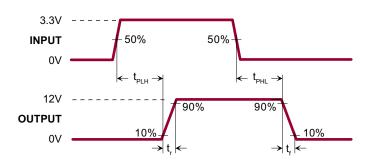
AC Electrical Characteristics $(V_H = V_{DD} = 12V, V_L = V_{SS} = GND = 0V, V_{OF} = 3.3V, T_A = 25^{\circ}C)$

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Sym	Parameter	Min	Тур	Max	Units	Conditions		
t _{irf}	Input or OE rise & fall time	-	-	10	ns	Logic input edge speed requirement		
t _{PLH}	Propagation delay when output is from low to high	-	7.0	-	ns			
t _{PHL}	Propagation delay when output is from high to low	-	7.0	-	ns	C _{LOAD} = 1000pF, see timing diagram		
t _r	Output rise time	-	6.0	_	ns	Input signal rise/fall time 2.0ns		
t _f	Output fall time	-	6.0	-	ns			
t _r - t _f	Rise and fall time matching	-	1.0	-				
It _{PLH} -t _{PHL} I	Propagation low to high and high to low matching	-	1.0	-	ns	For each channel		
$\Delta t_{\sf dm}$	Propagation delay matching	-	±2.0	_	ns	Device to device delay match		
t _{OE_ON}	Output anable time	-	200	-				
t _{OE_OFF}	Output enable time	-	9.0	-	ns			

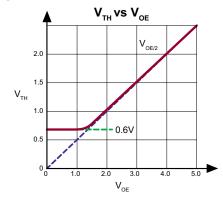
Logic Truth Table

Logic	Output		
OE			
Н	L	V _L	
Н	Н	V _H	
L	X	High Z	

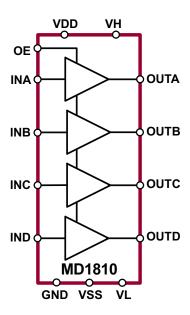
Timing Diagram



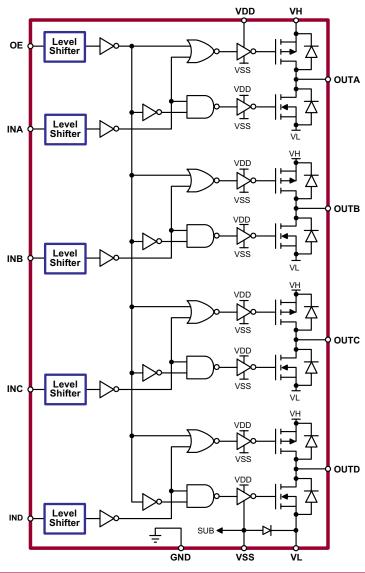
V_{TH} / V_{OE} Curve



Simplified Block Diagram

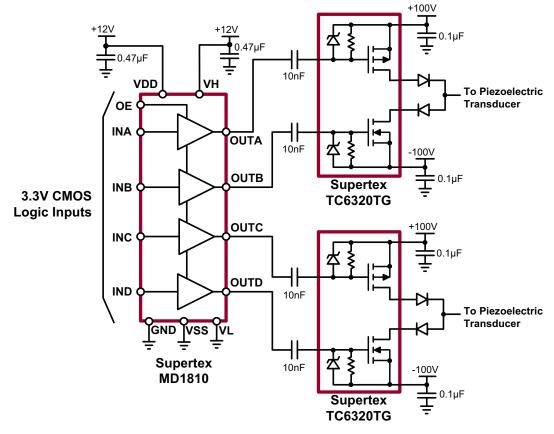


Detailed Block Diagram

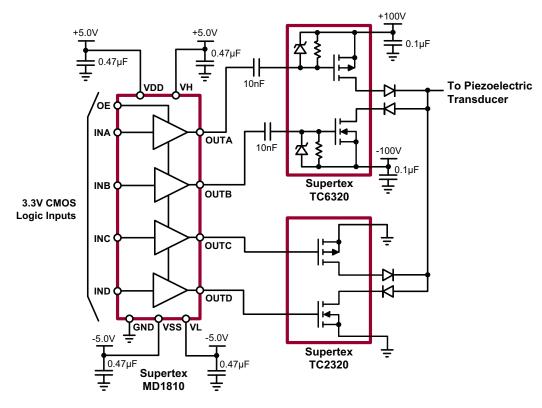


Typical Applications

2-Channel +100V to -100V Pulser



Single Channel ±100V to 0V Pulser



Application Information

For proper operation of the MD1810, low inductance bypass capacitors should be used on the various supply pins. The GND pin should be connected to the logic ground. The INA, INB INC, IND, and OE pins should be connected to a logic source with a swing of GND to OE, where OE is 1.8 to 5.0 V. Good trace practices should be followed corresponding to the desired operating speed. The internal circuitry of the MD1810 is capable of operating up to 100MHz, with the primary speed limitation being the loading effects of the load capacitance. Because of this speed and the high transient currents that result with capacitive loads, the bypass capacitors should be as close to the chip pins as possible. Unless the load specifically requires bipolar drive, the V_{ss} , and V_{ι} pins should have low inductance feed-through connections directly to a ground plane. If these voltages are not zero, then they need bypass capacitors in a manner similar to the positive power supplies. The power connection $V_{\tiny DD}$ should have a ceramic bypass capacitor to the ground plane with short leads and decoupling components to prevent resonance in the power leads.

The voltages of VH and VL decide the output signal levels. These two pins can draw fast transient currents of up to 2.0A, so they should be provided with an appropriate bypass

capacitor located next to the chip pins. A ceramic capacitor of up to 1.0µF may be appropriate, with a series ferrite bead to prevent resonance in the power supply lead coming to the capacitor. Pay particular attention to minimizing trace lengths, current loop area and using sufficient trace width to reduce inductance. Surface mount components are highly recommended. Since the output impedance of this driver is very low, in some cases it may be desirable to add a small series resistance in series with the output signal to obtain better waveform transitions at the load terminals. This will of course reduce the output voltage slew rate at the terminals of a capacitive load.

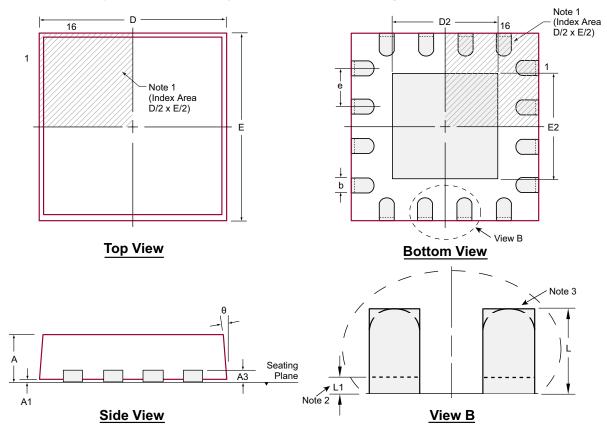
Pay particular attention that parasitic couplings are minimized from the output to the input signal terminals. The parasitic feedback may cause oscillations or spurious waveform shapes on the edges of signal transitions. Since the input operates with signals down to 1.8V even small coupled voltages may cause problems. Use of a solid ground plane and good power and signal layout practices will prevent this problem. Be careful that a circulating ground return current from a capacitive load cannot react with common inductance to cause noise voltages in the input logic circuitry.

Pin Description

Pin #	Function	Description					
1	INB	Logic input. Input logic high will cause the output to swing to VH. Input logic low will cause the output to swing to VL. Keep all logic inputs low until IC powered up.					
2	VL	Supply voltage for N-channel output stage.					
3	GND	Logic input ground reference.					
4	VL	Supply voltage for N-channel output stage.					
5	INC	Logic input. Input logic high will cause the output to swing to VH. Input logic low will					
6	IND	cause the output to swing to VL. Keep all logic inputs low until IC powered up.					
7	VSS	Low side supply voltage. VSS is also connected to the IC substrate. It is required to connect to the most negative potential of voltage supplies and powered-up first.					
8	OUTD	Outhout delivers					
9	OUTC	Output drivers					
10, 11	VH	Supply voltage for P-channel output stage.					
12	OUTB	Output drivers					
13	OUTA	Output drivers					
14	VDD	High side supply voltage.					
15	INA	Logic input. Input logic high will cause the output to swing to VH. Input logic low will cause the output to swing to VL. Keep all logic inputs low until IC powered up.					
16	OE	Output enable logic input. When OE is high, $(V_{\rm OE}^+V_{\rm GND}^-)/2$ sets the threshold transition between logic level high and low. When OE is low, all outputs are at high impedance. Keep OE low until IC powered up.					
S	ubstrate	The IC substrate is internally connected to the thermal pad. Thermal pad and VSS must be connected externally.					

16-Lead QFN Package Outline (K6)

4.00x4.00mm body, 1.00mm height (max), 0.65mm pitch



Notes:

- 1. A Pin 1 identifier must be located in the index area indicated. The Pin 1 identifier can be: a molded mark/identifier; an embedded metal marker; or a printed indicator.
- 2. Depending on the method of manufacturing, a maximum of 0.15mm pullback (L1) may be present.
- 3. The inner tip of the lead may be either rounded or square.

Symb	ol	Α	A1	А3	b	D	D2	E	E2	е	L	L1	θ
	MIN	0.80	0.00		0.25	3.85*	2.50	3.85*	2.50		0.30 [†]	0.00	0 °
Dimension (mm)	NOM	0.90	0.02	0.20 REF	0.30	4.00	2.65	4.00	2.65	0.65 BSC	0.40 [†]	-	-
()	MAX	1.00	0.05		0.35	4.15*	2.80	4.15*	2.80		0.50 [†]	0.15	14º

JEDEC Registration MO-220, Variation VGGC-2, Issue K, June 2006.

Drawings not to scale.

Supertex Doc.#: DSPD-16QFNK64X4P065, Version C041009.

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to http://www.supertex.com/packaging.html.)

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^{*} This dimension is not specified in the JEDEC drawing.

[†] This dimension differs from the JEDEC drawing.